

PATENT ABSTRACTS OF JAPAN

(11)Publication number : 2002-277500

(43)Date of publication of application : 25.09.2002

(51)Int.Cl. G01R 29/10

(21)Application number : 2001-075364 (71)Applicant : HITACHI LTD

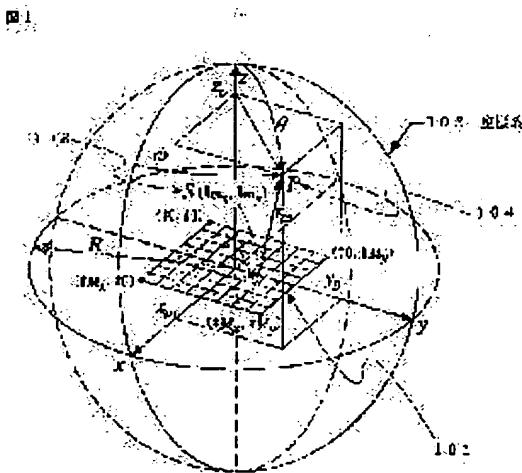
(22)Date of filing : 16.03.2001 (72)Inventor : KAMISAKA KOICHI
SUGA TAKU

(54) SURVEYING METHOD FOR ELECTROMAGNETIC WAVE GENERATION SOURCE

(57)Abstract:

PROBLEM TO BE SOLVED: To clarify which point of current is the cause of generation of a distant electric field in a current distribution on a measuring object electronic circuit board and electronic appliance and estimate how the variation of current flowing at an arbitrary point varies the distant electric field.

SOLUTION: The distant electric field due to all current on a measuring object electronic circuit board and electronic appliance is measured or calculated. A difference from the electric field by each current on a measuring object electronic circuit board and electronic appliance is obtained so that a contribution factor of generating distant electric field by a current at the point is calculated. Also by calculating the distant electric field by multiplying a coefficient to the current distribution, so that the variation of the distant electric field in the case of varying current on a measuring object electronic circuit board and electronic appliance is estimated.



LEGAL STATUS

[Date of request for examination] 08.03.2004

[Date of sending the examiner's decision of

[rejection]

[Kind of final disposal of application other than
the examiner's decision of rejection or
application converted registration]

[Date of final disposal for application]

[Patent number]

[Date of registration]

[Number of appeal against examiner's
decision of rejection]

[Date of requesting appeal against examiner's
decision of rejection]

[Date of extinction of right]